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3.3 V, 3.0 GHz Any Differential Clock IN to LVDS OUT ÷1/2/4/8, ÷2/4/8/16 Clock Divider

Description

The NB6N239S is a high-speed, low skew clock divider with two divider circuits, each having selectable clock divide ratios; $\div 1/2/4/8$ and $\div 2/4/8/16$. Both divider circuits drive LVDS compatible outputs. (More device information on page 7). The NB6N239S is a member of the ECLinPS MAXTM family of high performance clock products.

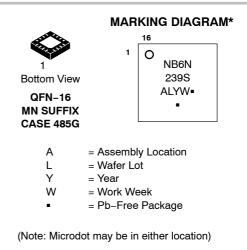
Features

- Maximum Clock Input Frequency, 3.0 GHz (1.5 GHz with ÷1)
- Input Compatibility with LVDS/LVPECL/CML/HSTL/HCSL
- Rise/Fall Time 120 ps Typical
- < 5 ps Typical Within Device Output Skew
- Example; 622.08 MHz Input Generates 38.88 MHz to 622.08 MHz Outputs
- Internal 50 Ω Termination Provided
- Random Clock Jitter < 2 ps RMS
- QA \div 1 Edge Aligned to QB \div n Edge
- Operating Range: $V_{CC} = 3.0 \text{ V}$ to 3.465 V with GND = 0 V
- Master Reset for Synchronization of Multiple Chips
- V_{BBAC} Reference Output
- Synchronous Output Enable/Disable
- TIA/EIA 644 Compliant
- These Devices are Pb-Free and are RoHS Compliant



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*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 11 of this data sheet.

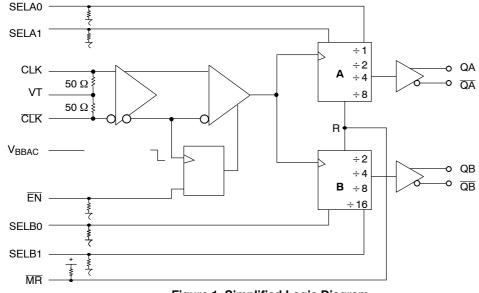
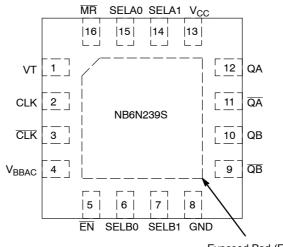


Figure 1. Simplified Logic Diagram



Exposed Pad (EP)

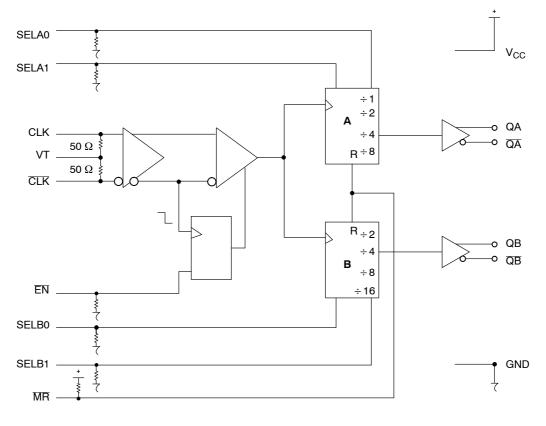
Figure 2. Pinout: QFN-16 (Top View)

Table 1. PIN DESCRIPTION

Pin	Name	I/O	Description
1	VT		Internal 100 Ω Center-Tapped Termination Pin for CLK and $\overline{\text{CLK}}$.
2	CLK	LVDS, LVPECL, CML, HCSL, HSTL Input	Noninverted Differential CLOCK Input.
3	CLK	LVDS, LVPECL, CML, HCSL, HSTL Input	Inverted Differential CLOCK Input.
4	V_{BBAC}		Output Voltage Reference for Capacitor Coupled Inputs, only.
5	EN*	LVCMOS/LVTTL Input	Synchronous Output Enable
6	SELB0*	LVCMOS/LVTTL Input	Clock Divide Select Pin
7	SELB1*	LVCMOS/LVTTL Input	Clock Divide Select Pin
8	GND	Power Supply	Negative Supply Voltage
9	QB	LVDS Output	Inverted Differential Output. Typically terminated with 100 Ω across differential outputs.
10	QB	LVDS Output	Noninverted Differential Output. Typically terminated with 100 Ω across differential outputs.
11	QA	LVDS Output	Inverted Differential Output. Typically terminated with 100 Ω across differential outputs.
12	QA	LVDS Output	Noninverted Differential Output. Typically terminated with 100 Ω across differential outputs.
13	V _{CC}	Power Supply	Positive Supply Voltage.
14	SELA1*	LVCMOS/LVTTL Input	Clock Divide Select Pin
15	SELA0*	LVCMOS/LVTTL Input	Clock Divide Select Pin
16	MR**	LVCMOS/LVTTL Input	Master Reset Asynchronous, Default Open High, Asserted LOW
	EP	Power Supply (OPT)	The Exposed Pad on the QFN-16 package bottom is thermally connected to the die for improved heat transfer out of package. The pad is electrically connected to the die, and is recommended to be electrically and thermally connected to GND on the PC board.

*Pins will default LOW when left OPEN.

**Pins will default HIGH when left OPEN.



V_{BBAC} -

Figure 3. Logic Diagram

Table 2. FUNCTION TABLE

CLK	EN*	MR**	FUNCTION
ト イ X	LHX	エエー	Divide Hold Q Reset Q

Table 3. CLOCK DIVIDE SELECT, QA OUTPUTS

SELA1*	SELA0*	QA Outputs
L L H H		Divide by 1 Divide by 2 Divide by 4 Divide by 8

Table 4. CLOCK DIVIDE SELECT, QB OUTPUTS

SELB1*	SELB0*	QB Outputs
L	L	Divide by 2
L	H	Divide by 4
H	L	Divide by 8
H	H	Divide by 16

X = Don't Care

*Pins will default LOW when left OPEN. **Pins will default HIGH when left OPEN.

Table 5. ATTRIBUTES

Characteristics	Value	
Internal Input Pulldown Resistor Internal Input Pullup Resistor		75 kΩ 75 kΩ
ESD Protection	> 1500 V > 100 V > 1000 V	
Moisture Sensitivity, Indefinite Time Out of I	Drypack (Note 1)	Pb-Free Pkg
	QFN-16	Level 1
Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in
Transistor Count		370
Meets or exceeds JEDEC Spec EIA/JESD7	8 IC Latchup Test	

1. For additional Moisture Sensitivity information, refer to Application Note AND8003/D.

Table 6. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{CC}	Positive Mode Power Supply	GND = 0 V		3.6	V
VI	Input Voltage	GND = 0 V	$\text{GND} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}}$	3.6	V
I _{SC}	Output Short Circuit Current Line-to-Line Line-to-GND TIA/EIA – 644 Compliant			12 24	mA mA
I _{BBAC}	V _{BBAC} Sink/Source Current			± 0.5	mA
T _A	Operating Temperature Range			-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm		41.6 35.2	°C/W °C/W
θJC	Thermal Resistance (Junction-to-Case)	Standard Board		4.0	°C/W
T _{sol}	Wave Solder Pb-Free			265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 7. DC CHARACTERISTICS, CLOCK INPUTS, LVDS OUTPUTS

(V_{CC} = 3.0 V to 3.465 V, GND = 0 V)

			-40°C			25°C					
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{CC}	Power Supply Cur- rent (Inputs and Outputs OPEN)				35	45	55				mA
V _{OH}	Output HIGH Voltage (Notes 2)			1600			1600			1600	mV
V _{OL}	Output LOW Voltage (Notes 2)	900			900			900			mV
V _{OD}	Differential Output Voltage (Figure 21)	250		450	250		450	250		450	mV
ΔV_{OD}	V _{OD} Magnitude Change	0		50	0		50	0		50	mV
V _{OS}	Offset Voltage (Figure 21)	1125		1375	1125		1375	1125		1375	mV
ΔV_{OS}	V _{OS} Magnitude Change	0		50	0		50	0		50	mV
DIFFER	ENTIAL INPUT DRIV	VEN SINGLE	E-ENDE	D (Figures 7	, 10)						
V _{th}	Input Threshold Reference Voltage (Note 3)	100		V _{CC} – 100	100		V _{CC} – 100	100		V _{CC} - 100	mV
V _{IH}	Single-ended Input HIGH Voltage	V _{th} + 100		V _{CC}	V _{th} + 100		V _{CC}	V _{th} + 100		V _{CC}	mV
VIL	Single-ended Input LOW Voltage	GND		V _{th} – 100	GND		V _{th} – 100	GND		V _{th} – 100	mV
V _{BBAC}	Output Voltage Ref- erence @ 100 µA (Note 6)	V _{CC} -1460 1840	V _{CC} - 1330	V _{CC} -1200	V _{CC} -1460	V _{CC} - 1340	V _{CC} -1200	V _{CC} -1460	V _{CC} - 1350	V _{CC} -1200	mV
	V _{CC} =		1970	2100	1840	1960	2100	1840	1950	2100	

V _{IHD}	Differential Input HIGH Voltage	100		V _{CC}	100		V _{CC}	100		V _{CC}	mV
V _{ILD}	Differential Input LOW Voltage	GND		V _{CC} - 100	GND		V _{CC} - 100	GND		V _{CC} - 100	mV
V _{CMR}	Input Common Mode Range (Dif- ferential Cross- point Voltage) (Note 4)	50		V _{CC} – 50	50		V _{CC} – 50	50		V _{CC} – 50	mV
V _{ID}	Differential Input Voltage (V _{IHD(CLK}) – V _{ILD(CLK}) and (V _{IHD(CLK}) – V _{ILD(CLK})	100		V _{CC} – GND	100		V _{CC} – GND	100		V _{CC} – GND	mV
R _{TIN}	Internal Input Ter- mination Resistor	45	50	55	45	50	55	45	50	55	Ω

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

2. Outputs loaded with 100 Ω across LVDS outputs.

V_{th} is applied to the complementary input when operating in single–ended mode.
 VCMR_{MIN} varies 1:1 with GND, VCMR_{MAX} varies 1:1 with V_{CC}.
 Input and output voltage swing is a single–ended measurement operating in differential mode.

6. V_{BBAC} used to rebias capacitor-coupled inputs only (see Figures 16 and 17).

Symbol	Characteristic	Min	Тур	Max	Unit
VIH	Input HIGH Voltage (LVCMOS/LVTTL)	2.0		V _{CC}	V
V _{IL}	Input LOW Voltage (LVCMOS/LVTTL)	GND		0.8	V
I _{IH}	Input HIGH Current	-150		150	μA
IIL	Input LOW Current	-150		150	μA

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

			-40°C	;		25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f _{inMAX}	Maximum Input CLOCK Frequency QA/QB = ($\div 2$, $\div 4$, $\div 8$, $\div 16$) QA = ($\div 1$)	3.0 1.5			3.0 1.5			3.0 1.5			GHz
V _{OUTPP}	$\begin{array}{ll} & \text{Output Voltage Amplitude (Notes 9, 10)} \\ & \text{QA}(\div 2, 4, 8), \text{QB}(\div n) & f_{\text{in}} \leq 3.0 \text{ GHz} \\ & \text{QA}(\div 1), \text{QB}(\div n) & f_{\text{in}} \leq 1.5 \text{ GHz} \end{array}$	200 200	350 350	450 450	200 200	350 350	450 450	200 200	350 350	450 450	mV
t _{PLH} , t _{PHL}	Propagation Delay to CLK, Qn Output Differential @ 50 MHz MR, Qn	550 420		780 660	550 420		780 660	550 420		780 660	ps
t _{RR}	Reset Recovery	0	-90		0	-90		0	-90		ps
t _s	Setup Time @ 50 MHz EN, CLK SELA/B, CLK	0 0	-60 -300		0 0	-60 -300		0 0	-60 -300		ps
t _h	Hold Time @ 50 MHz CLK, EN CLK, SELA/B	150 700	65 200		150 700	65 200		150 700	65 200		ps
t _{skew}	Within-Device Skew @ 50 MHz(Note 8)Device-to-Device Skew(Note 8)Duty Cycle Skew(Note 8)		5 25 25	30 80 40		5 30 30	30 90 45		6 30 30	35 90 45	ps
t _{PW}	Minimum Pulse Width MR	550			550			550			ps
t _{JITTER}	RMS Random Clock Jitter			2			2			2	ps
V _{INPP}	Input Voltage Swing (Differential Configuration) (Note 9)	100		V _{CC} -GND	100		V _{CC} -GND	100		V _{CC} -GND	mV
t _r t _f	Output Rise/Fall Times @ 50 MHz Qn, Qn (20% - 80%) Qn	70	120	190	70	120	190	70	120	190	ps

Table 9. AC CHARACTERISTICS V_{CC} = 3.0 V to 3.465 V; GND = 0 V (Note 7)

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

7. Measured using a 750 mV, 50% duty cycle clock source. All loading with 100 Ω across LVDS outputs.

8. Skew is measured between outputs under identical transitions and conditions. Duty cycle skew is defined only for differential operation

9. Input and output voltage swing is a single–ended measurement operating in differential mode.
10. Output Voltage Amplitude (V_{OHCLK} - V_{OLCLK}) at input CLOCK frequency, f_{in}. The output frequency, f_{out}, is the input CLOCK frequency divided by n, f_{out} = f_{in} ÷ n. Input CLOCK frequency is ≤3.0 GHz.

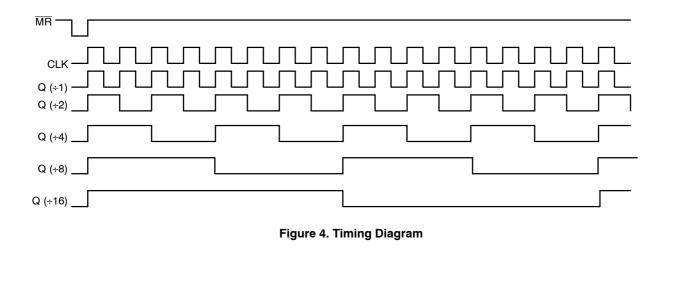
Application Information

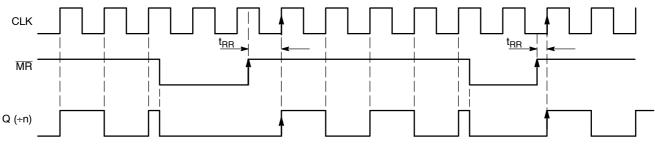
The NB6N239S is a high–speed, low skew clock divider with two divider circuits, each having selectable clock divide ratios; $\div 1/2/4/8$ and $\div 2/4/8/16$. Both divider circuits drive differential LVDS compatible outputs. The internal dividers are synchronous to each other. Therefore, the common output edges are precisely aligned.

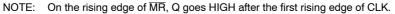
The NB6N239S clock inputs can be driven by a variety of differential signal level technologies including LVDS, LVPECL, HCSL, HSTL, or CML. The differential clock input buffer employs a pair of internal 50 Ω termination resistors in a 100 Ω center–tapped configuration and accessible via the VT pin. This feature provides transmission line termination on–chip, at the receiver end, eliminating external components. The V_{BBAC} reference output is recommended to be used to rebias differential or

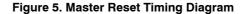
single–ended input capacitor–coupled CLOCK signals. For the capacitor–coupled CLK and/or $\overline{\text{CLK}}$ inputs, V_{BBAC} should be connected to the V_T pin and bypassed to ground with a 0.01 μ F capacitor. Inputs CLK and $\overline{\text{CLK}}$ must be signal driven or auto oscillation may result.

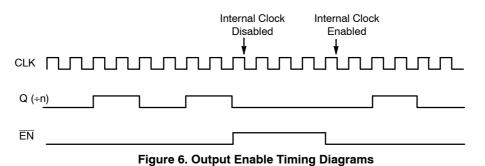
The common enable $(\overline{\text{EN}})$ is synchronous so that the internal divider flip-flops will only be enabled/disabled when the internal clock is in the LOW state. This avoids any chance of generating a runt pulse on the internal clock when the device is enabled/disabled, as can happen with an asynchronous control. The internal enable flip-flop is clocked on the falling edge of the input clock. Therefore, all associated specification limits are referenced to the negative edge of the clock input.



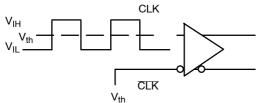








The \overline{EN} signal will "freeze" the internal divider flip-flops on the first falling edge of CLK after its assertion. The internal divider flip-flops will maintain their state during the freeze. When \overline{EN} is deasserted (LOW), and after the next falling edge of CLK, then the internal divider flip-flops will "unfreeze" and continue to their next state count with proper phase relationships.





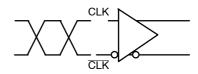


Figure 8. Differential Inputs Driven Differentially

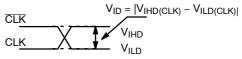
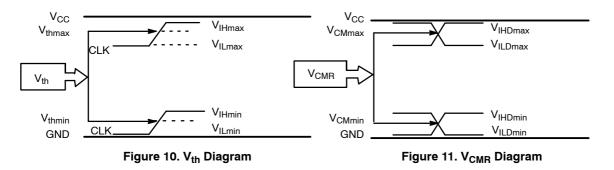
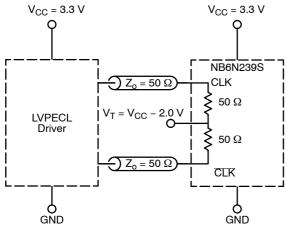


Figure 9. Differential Inputs Driven Differentially







•) Z_o = 50 Ω

 $V_T = V_{CC}$ O

 $Z_0 = 50 \Omega$

Figure 14. Standard 50 Ω Load CML Interface

 $V_{CC} = 3.3 V$

CML

Driver

V_{CC} = 3.3 V

NB6N239S

CLK

50 Ω

50 Ω

CLK

6 GND

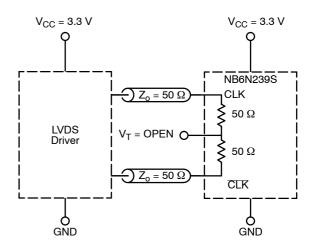


Figure 13. LVDS Interface

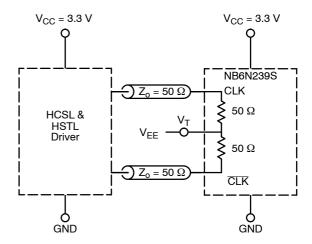
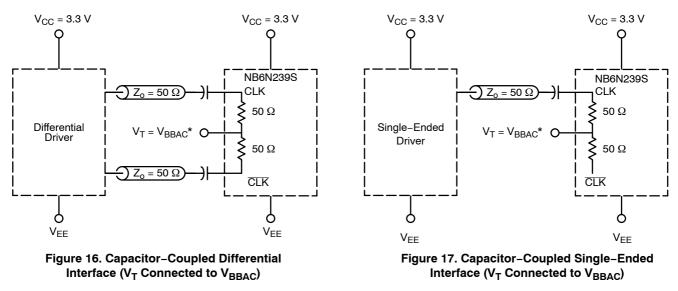


Figure 15. Standard 50 Ω Load HCSL & HSTL Interface



*VBBAC bypassed to ground with a 0.01 μF capacitor.

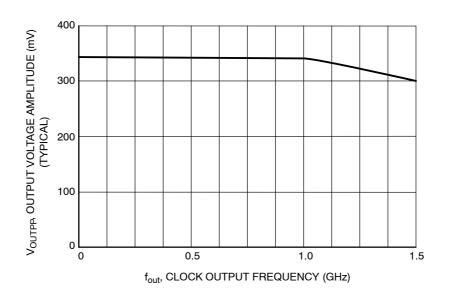


Figure 18. Output Voltage Amplitude (V_{OUTPP}) versus Output Clock Frequency at 25°C (Typical) f_{out} (QA/QB) = $f_{in} \div n$; For n = 2, 4, 8, 16; $f_{in} \le 3.0$ GHz For n = 1; $f_{in} \le 1.5$ GHz

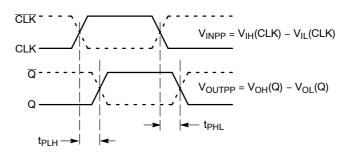


Figure 19. AC Reference Measurement

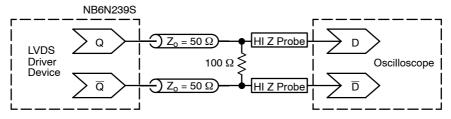


Figure 20. Typical LVDS Termination for Output Driver and Device Evaluation, If Receiver Has On-chip Termination, 100 Ω Resistor is Not Needed

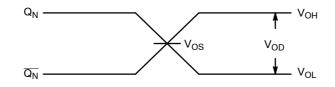


Figure 21. LVDS Output

ORDERING INFORMATION

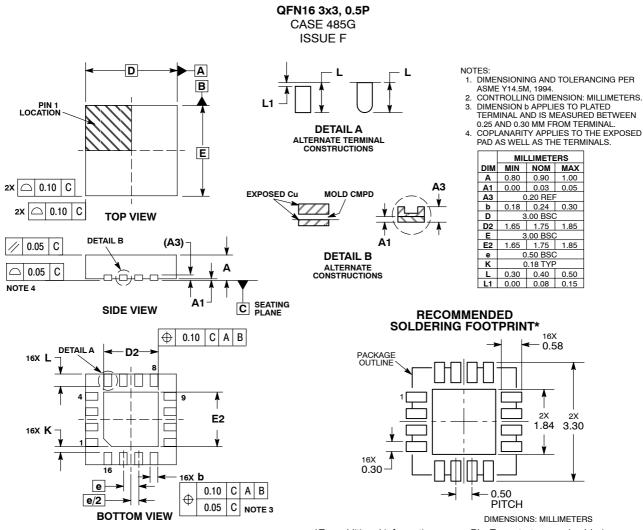
Device	Package	Shipping [†]
NB6N239SMNG	QFN-16, 3 x 3 mm (Pb-Free)	123 Units / Rail
NB6N239SMNR2G	QFN-16, 3 x 3 mm (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Resource Reference of Application Notes

AN1405/D	-	ECL Clock Distribution Techniques
AN1406/D	-	Designing with PECL (ECL at +5.0 V)
AN1503/D	-	ECLinPS [™] I/O SPiCE Modeling Kit
AN1504/D	-	Metastability and the ECLinPS Family
AN1568/D	-	Interfacing Between LVDS and ECL
AN1672/D	-	The ECL Translator Guide
AND8001/D	-	Odd Number Counters Design
AND8002/D	-	Marking and Date Codes
AND8020/D	-	Termination of ECL Logic Devices
AND8066/D	-	Interfacing with ECLinPS
AND8090/D	_	AC Characteristics of ECL Devices

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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